Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
10/691,118	RIKHY ET AL.
Examiner	Art Unit
Benny Q. Tieu	2614

	SEARCHED					
Class	Subclass	Date	Examiner			
379	265.02- 266.1 309	1/5/2007	вот			
370	270 352 354					
709	201 202					
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOT (INCLUDING SEARCH		)
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PLUS	1/5/2007	BQT
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